


<b>Search Notes</b>  	<b>Application/Control No.</b>  10674730	<b>Applicant(s)/Patent Under Reexamination</b>  WALTHO ET AL.
	<b>Examiner</b>  Lee, Siu M	<b>Art Unit</b>  2611

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	346, 224, 227, 254, 285	1/25/2007	Siu M. Lee

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	1/25/2007	Siu M. Lee
Discuss with Chieh Fan	1/25/2007	Siu M. Lee

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>